## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | TSUNEHIKO WATANABE | Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0168664 A1	11-2002	Murray et al.	435/6
*	В	US-2003/0100999 A1	05-2003	Markowitz, Victor M.	702/20
*	С	US-2004/0024535 A1	02-2004	Lincoln et al.	702/20
*	D	US-6,928,368 B1	08-2005	Bulla et al.	702/19
*	Ε	US-6,931,396 B1	08-2005	Topaloglou et al.	707/4
*	F	US-7,133,780 B2	11-2006	Siani-Rose et al.	. 702/20
	G	US-			
	Н	US-			
	L	US-			
,	J	US-			
	K	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N			,		
	0					
	Р	·				·
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
-	w	
	x	

<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.